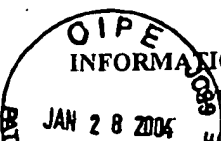


FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 500841.01	APPLICATION NO. 09/779,010
 <p>Use several sheets if necessary)</p>		APPLICANT(S) Keith R. Slavin	
		FILING DATE February 7, 2001	GROUP ART UNIT 2123

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WS	AA	5,889,894	03/30/99	Ito et al.	382	300	
WS	AB	6,535,651 B1	03/18/03	Aoyama et al.	382	300	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

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FEB. 02 2004

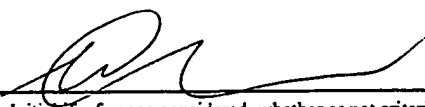
echnology Center 2100

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AK							
	AL							
	AM							
	AN							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

WS	AO	Catmull, E. et al., "A Class of Local Interpolating Splines", Computer Aided Geometric Design, New York, Academic Press, 1974, pp. 317-326.
WS	AP	Hill, F.S., Jr., "Computer Graphics Using Open GL", New Jersey, Prentice-Hall, 2001, pp. 643-653.
WS	AQ	Kochanek, D. et al., "Interpolating Splines with Local Tension, Continuity, and Bias Control", Computer Graphics, Vol. 18, No. 13, July 1984. pp. 33-41.

EXAMINER	DATE CONSIDERED
	3/14/2005
* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).	

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 500841.01		APPLICATION NO. 09/779,010	
<div style="display: flex; align-items: center;"> <div style="border: 1px solid black; border-radius: 50%; padding: 5px; text-align: center; margin-right: 10px;"> MAY 30 2003 3642 RECEIVED </div> <div> INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i> </div> </div>				APPLICANT(S) Keith R. Slavin			
				FILING DATE February 7, 2001		GROUP ART UNIT 2123	

U.S. PATENT DOCUMENTS							
EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<i>WS</i> <i>WS</i>	AA	4,282,546	08/04/81	Reitmeier	358	22	
	AB	4,578,812	03/25/86	Yui	382	41	
	AC	4,630,307	12/16/86	Cok	382	25	
	AD	5,054,100	10/01/91	Tai	382	47	
	AE	5,703,965	12/30/97	Fu et al.	382	232	
	AF	5,930,407	07/27/99	Jensen	382	300	
	AG	5,995,682	11/30/99	Pawlicki et al.	382	300	
	AH	6,018,597	01/25/00	Maltsev et al.	382	260	
	AI						
	AJ						
AK						RECEIVED	
AL						JUN 02 2003	
AM						Technology Center 2100	

FOREIGN PATENT DOCUMENTS								
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION			
					YES	NO		
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AO								
AP								

OTHER PRIOR ART <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>	
AQ	
AR	

EXAMINER <div style="text-align: center; font-size: 2em;"><i>[Signature]</i></div>	DATE CONSIDERED <div style="text-align: center; font-size: 1.5em;"><i>3/14/2005</i></div>
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